Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination KOBAYASHI, HISASHI	
Brian Nash	3721	

SEARCHED							
Class	Subclass	Date	Examiner				
227	131,129, 124,153, 155,5,6,7	3/13/2006	BN				
227	108,110,	3/13/2006	BN				
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOT (INCLUDING SEARCH		)
	DATE	EXMR
227 (patents only) text, IDS, inventor search - via EAST	3/13/2006	BN
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